

## FDN357N

# N-Channel Logic Level Enhancement Mode Field Effect Transistor

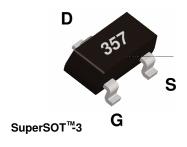
### **General Description**

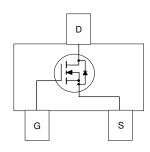
SuperSOT<sup>™</sup>-3 N-Channel logic level enhancement mode power field effect transistors are produced using Fairchild's proprietary, high cell density, DMOS technology. This very high density process is especially tailored to minimize on-state resistance. These devices are particularly suited for low voltage applications in notebook computers, portable phones, PCMCIA cards, and other battery powered circuits where fast switching, and low in-line power loss are needed in a very small outline surface mount package.

### **Features**

- 1.9 A, 30 V,  $R_{DS(ON)} = 0.090 \Omega$  @  $V_{GS} = 4.5 \text{ V}$  $R_{DS(ON)} = 0.060 \Omega$  @  $V_{GS} = 10 \text{ V}$ .
- Industry standard outline SOT-23 surface mount package using proprietary SuperSOT<sup>TM</sup>-3 design for superior thermal and electrical capabilities.
- High density cell design for extremely low R<sub>DS(ON)</sub>.
- Exceptional on-resistance and maximum DC current capability.







## **Absolute Maximum Ratings** $T_A = 25^{\circ}\text{C}$ unless other wise noted

Symbol	Parameter		FDN357N	Units
/ <sub>DSS</sub>	Drain-Source Voltage		30	V
/ <sub>GSS</sub>	Gate-Source Voltage - Continuous		±20	V
l <sub>D</sub>	Drain/Output Current - Continuous		1.9	Α
	- Pulsed		10	
$P_{D}$	Maximum Power Dissipation	(Note 1a)	0.5	W
		(Note 1b)	0.46	
J,T <sub>STG</sub>	Operating and Storage Temperature Range		-55 to 150	~
HERMA	L CHARACTERISTICS	<u>.</u>		
R <sub>eJA</sub>	Thermal Resistance, Junction-to-Ambient (Note 1a)		250	°C/W
R <sub>⊎C</sub>	Thermal Resistance, Junction-to-Case (Note 1)		75	°C/W

Symbol	Parameter	Conditions		Min	Тур	Max	Units
OFF CHAR	ACTERISTICS	<u> </u>		•			
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		30			٧
$\Delta BV_{DSS}/\Delta T_{J}$	Breakdown Voltage Temp. Coefficient	I <sub>D</sub> = 250 μA, Referenced to 25 °C			36		mV/°C
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	$V_{DS} = 24 \text{ V}, \ V_{GS} = 0 \text{ V}$				1	μΑ
			T <sub>.</sub> = 55 ℃			10	μΑ
I <sub>GSSF</sub>	Gate - Body Leakage, Forward	$V_{GS} = 20 \text{ V}, V_{DS} = 0 \text{ V}$				100	nA
I <sub>GSSB</sub>	Gate - Body Leakage, Reverse	$V_{GS} = -20 \text{ V}, V_{DS} = 0 \text{ V}$				-100	nA
ON CHARA	CTERISTICS (Note)						
V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu\text{A}$		1	1.6	2	٧
$\Delta V_{GS(th)}/\Delta T_{J}$	Gate Threshold Voltage Temp. Coefficient	I <sub>D</sub> = 250 μA, Referenced to 25 °C			-3.6		mV/°C
R <sub>DS(ON)</sub>	Static Drain-Source On-Resistance	$V_{GS} = 4.5 \text{ V}, I_D = 1.9 \text{ A}$			0.081	0.09	Ω
20(014)			T, =125℃		0.11	0.14	
		$V_{GS} = 10 \text{ V}, I_{D} = 2.2 \text{ A}$			0.053	0.06	
I <sub>D(ON)</sub>	On-State Drain Current	$V_{GS} = 4.5 \text{ V}, \ V_{DS} = 5 \text{ V}$		5			Α
g <sub>FS</sub>	Forward Transconductance	$V_{DS} = 5 \text{ V}, I_{D} = 1.9 \text{ A}$			5		S
DYNAMIC (	CHARACTERISTICS	-		•		·	
C <sub>iss</sub>	Input Capacitance	$V_{DS} = 10 \text{ V}, \ V_{GS} = 0 \text{ V},$ f = 1.0  MHz			235		pF
C <sub>oss</sub>	Output Capacitance	f = 1.0 MHz			145		pF
C <sub>rss</sub>	Reverse Transfer Capacitance				50		pF
SWITCHING	CHARACTERISTICS (Note)	•					
t <sub>D(on)</sub>	Turn - On Delay Time	$V_{DD} = 10 \text{ V}, \ I_D = 1 \text{ A},$ $V_{GS} = 10 \text{ V}, \ R_{GEN} = 6 \Omega$			5	10	ns
ţ,	Turn - On Rise Time				12	22	ns
$t_{D(off)}$	Turn - Off Delay Time				12	22	ns
t <sub>r</sub>	Turn - Off Fall Time				3	8	ns
$Q_g$	Total Gate Charge	$V_{DS} = 10 \text{ V}, I_{D} = 1.9 \text{ A},$			4.2	5.9	nC
$Q_{gs}$	Gate-Source Charge	V <sub>GS</sub> = 5 V			1.3		nC
$Q_{gd}$	Gate-Drain Charge				1.7		nC
DRAIN-SO	URCE DIODE CHARACTERISTICS AND M	AXIMUM RATINGS					
l <sub>s</sub>	Maximum Continuous Drain-Source Diode Forward Current					0.42	Α
V <sub>SD</sub>	Drain-Source Diode Forward Voltage	$V_{GS} = 0 \text{ V}, I_{S} = 0.42 \text{ A} \text{ (Note)}$			0.71	1.2	V

Note:

Typical  $R_{\text{B,M}}$  using the board layouts shown below on 4.5"x5" FR-4 PCB in a still air environment :



a. 250°C/W when mounted on a 0.02 in² pad of 2oz Cu.



 b. 270°C/W when mounted on a 0.001 in² pad of 2oz Cu.

Scale 1 : 1 on letter size paper

2. Pulse Test: Pulse Width  $\leq 300 \mu s,$  Duty Cycle  $\leq 2.0\%.$ 

<sup>1.</sup> R<sub>BAR</sub> is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. R<sub>BAC</sub> is guaranteed by design while R<sub>BCA</sub> is determined by the user's board design.

## **Typical Electrical Characteristics**

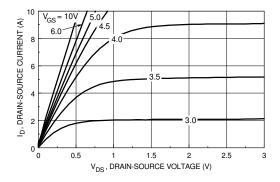


Figure 1. On-Region Characteristics.

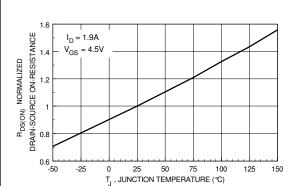


Figure 3. On-Resistance Variation with Temperature.

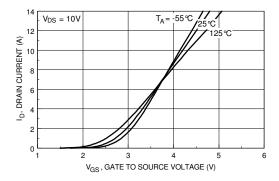


Figure 5. Transfer Characteristics.

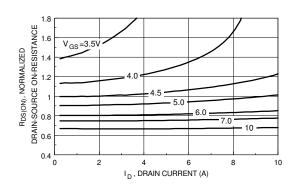


Figure 2. On-Resistance Variation with Drain Current and Gate

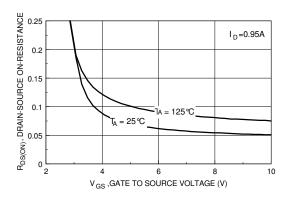


Figure 4. On-Resistance Variation with Gate-to-Source Voltage.

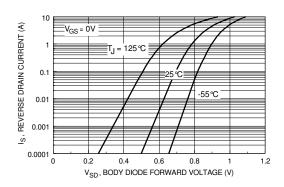


Figure 6. Body Diode Forward Voltage
Variation with Source Current
and Temperature.

## **Typical Electrical And Thermal Characteristics**

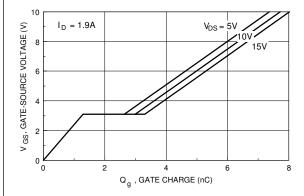


Figure 7. Gate Charge Characteristics.

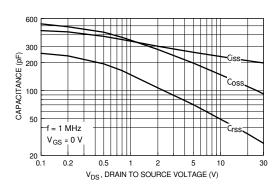


Figure 8. Capacitance Characteristics.

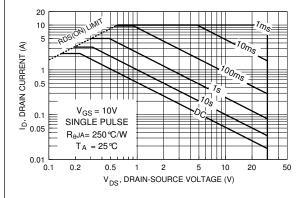


Figure 9. Maximum Safe Operating Area.

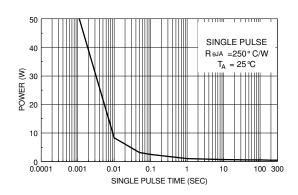


Figure 10. Single Pulse Maximum Power Dissipation.

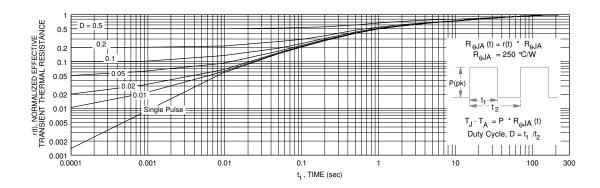


Figure 11. Transient Thermal Response Curve.

Note: Thermal characterization performed using the conditions described in note 1a. Transient thermal response will change depending on the circuit board design.

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